



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



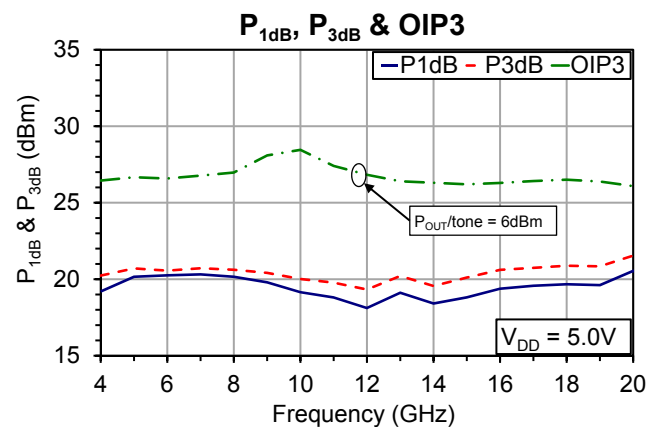
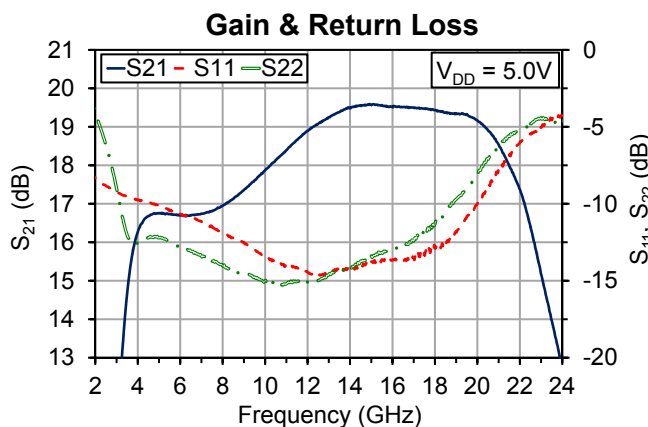
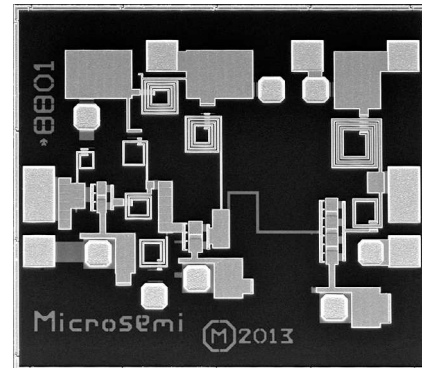
5-20GHz, 20dBm P_{3dB} , 18dB Gain Wideband Amplifier

Features

- 18dB gain with positive gain slope at 5V
- 19dB gain with positive gain slope at 3.3V
- 19dBm P_{1dB} with 26dBm OIP3 at 5V
- ± 1 dB power flatness
- Input and Output matched to 50 Ω
- 1.35mm x 1.5mm x 0.1mm die size

Applications

- Instrumentation
- Electronic warfare
- Microwave communications
- Radar



Typical Performance (CW, Typical Device, RF Probe): $T_A = 25^\circ\text{C}$, $V_{D1} = V_{D2} = 5\text{V}$

Parameter	Min	Typ	Max	Units
Frequency	5	-	20	GHz
Small Signal Gain	17.0	18.5	19.5	dB
Input Return Loss	10	12	14	dB
Output Return Loss	8	13	15	dB
Output Power, P_{1dB}	18.0	19.0	20.5	dBm
Output Power P_{3dB}	19.3	20.0	21.5	dBm
Output IP3	-	26	-	dBm
Drain Current	-	105	-	mA

Table 1: Absolute Maximum Ratings, Not Simultaneous

Parameter	Value	Units
Drain Voltage (V_{D1}, V_{D2})	+5.5	V
Input Power (P_{IN})	24	dBm
Operating Channel Temperature	150 ¹	°C
Operating Ambient Temperature (T_A)	-55 to +85	°C
Storage Temperature	-65 to 150	°C
Thermal Resistasnce, Channel to Die Backside	TBD (80 est)	°C/W

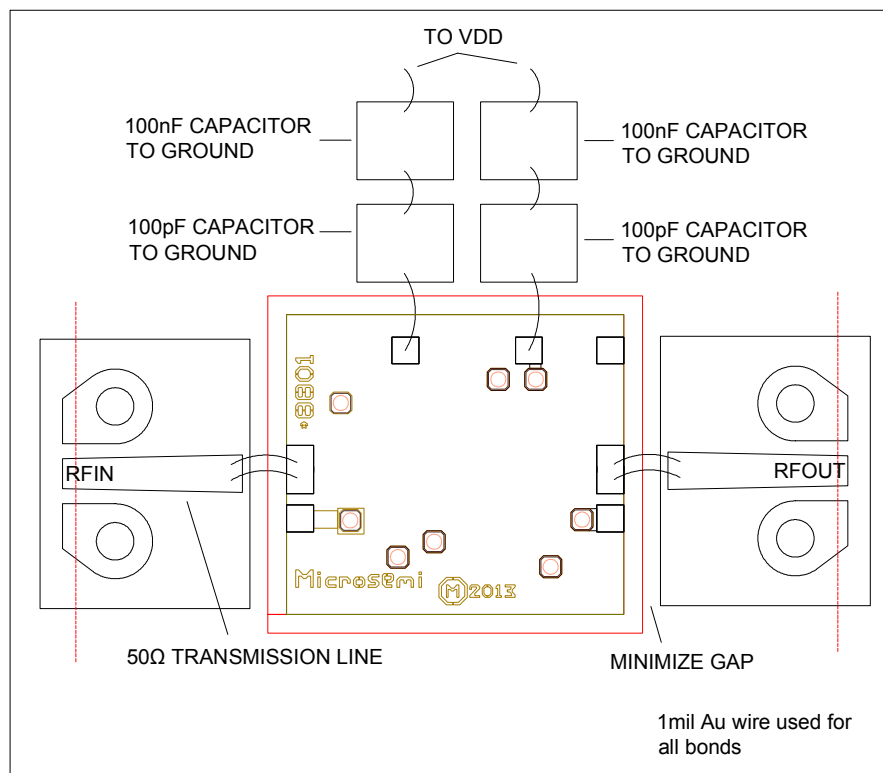


Caution, ESD Sensitive Device

¹ MTTF > 10⁸ hours at $T_C = 150^\circ\text{C}$
Table 2: Specifications (CW, 100% Test): $T_A = 25^\circ\text{C}$, $V_{D1} = V_{D2} = 5\text{V}$

Parameter	Frequency	Min	Max	Units
I_{DD}	-	-	160	mA
Small Signal Gain	6GHz	13.5	-	dB
Output Power, P_{1dB}	6GHz	17.5	-	dBm
Small Signal Gain	18GHz	16.5	-	dB
Output Power, P_{1dB}	18GHz	17.5	-	dBm

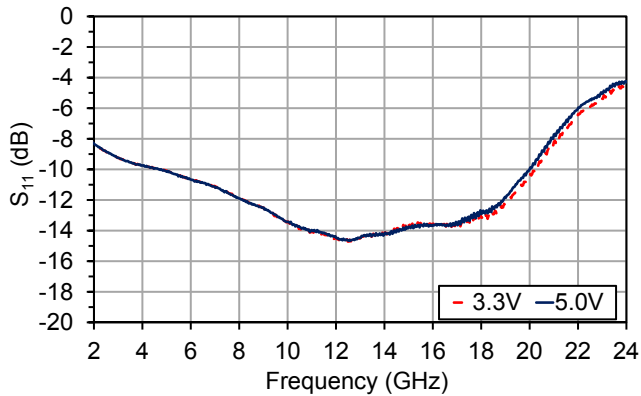
RF Probe Measurement Set-Up With Reference Planes¹


¹ Reference planes are the same for S-parameter files downloadable on www.microsemi.com/mmics

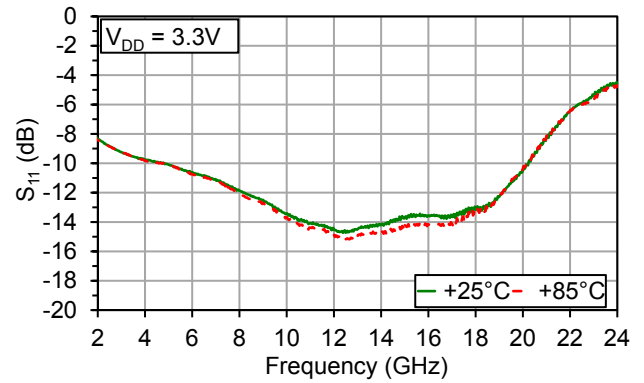
Typical Performance, RF Probe

$V_{D1} = V_{D2} = 5V$, $I_{DD} = 105mA$, $T_A = 25^\circ C$ unless otherwise noted

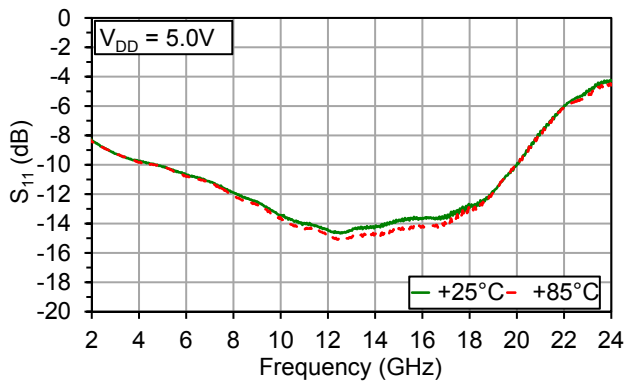
S_{11} Over V_{DD}



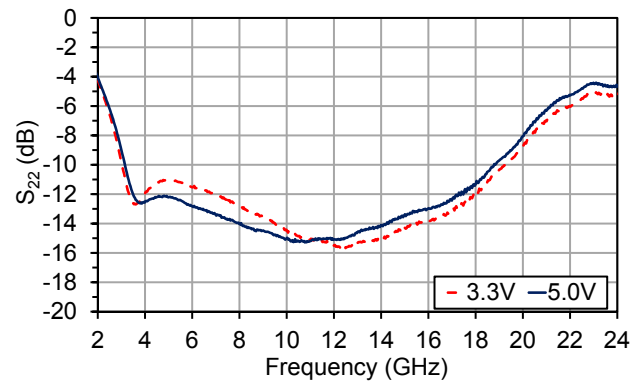
S_{11} Over Temperature, $V_{DD} = 3.3V$



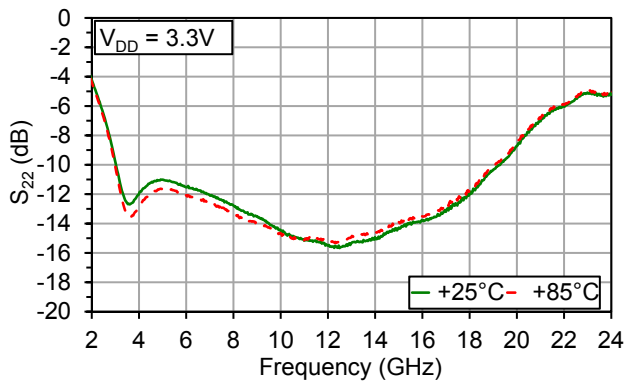
S_{11} Over Temperature, $V_{DD} = 5.0V$



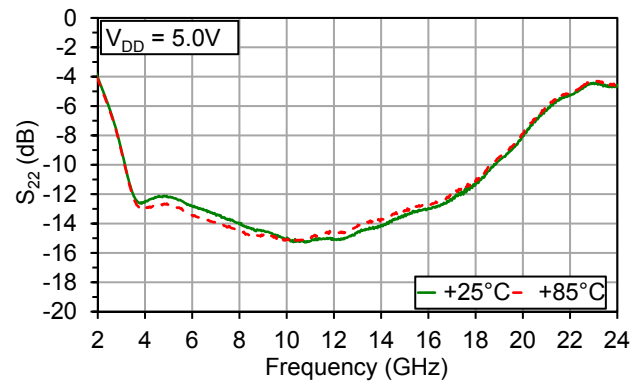
S_{22} Over V_{DD}



S_{22} Over Temperature, $V_{DD} = 3.3V$



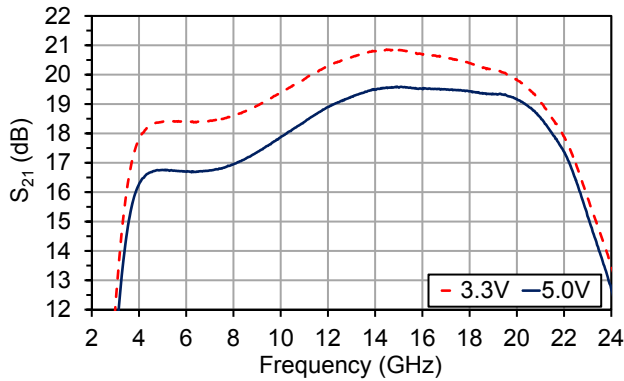
S_{22} Over Temperature, $V_{DD} = 5.0V$



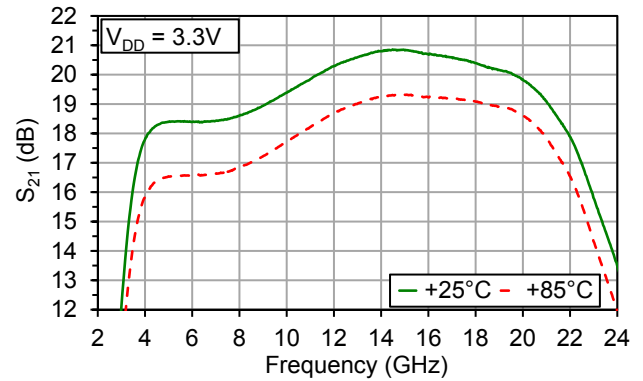
Typical Performance, RF Probe

$V_{D1} = V_{D2} = 5V$, $I_{DD} = 105mA$, $T_A = 25^\circ C$ unless otherwise noted

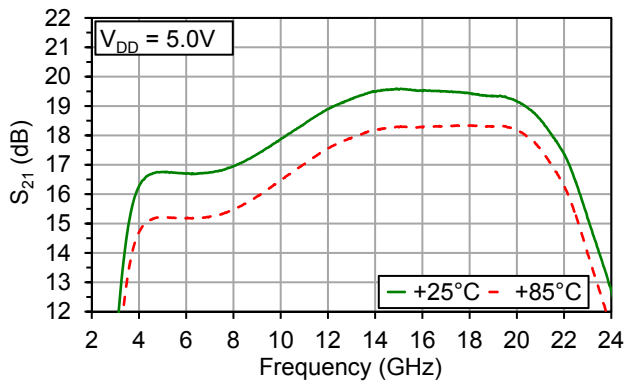
S_{21} Over V_{DD}



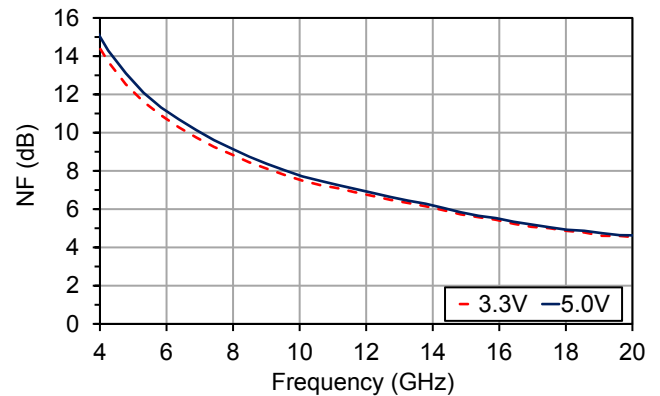
S_{21} Over Temperature, $V_{DD} = 3.3V$



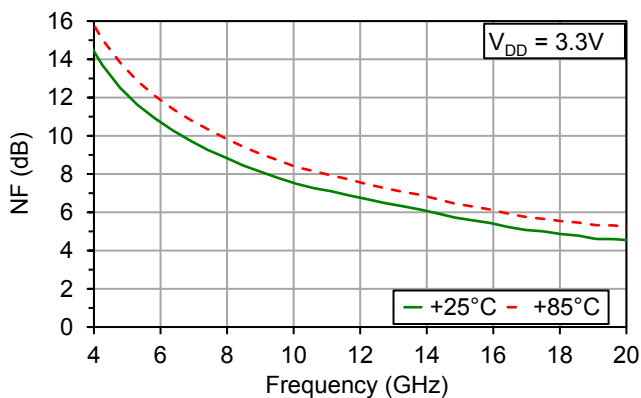
S_{21} Over Temperature, $V_{DD} = 5.0V$



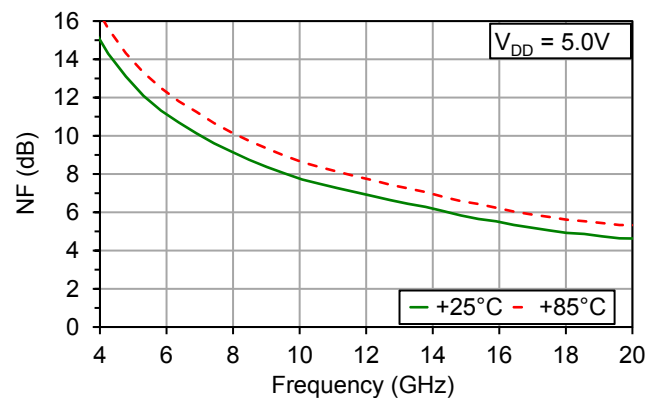
NF Over V_{DD}



NF Over Temperature, $V_{DD} = 3.3V$



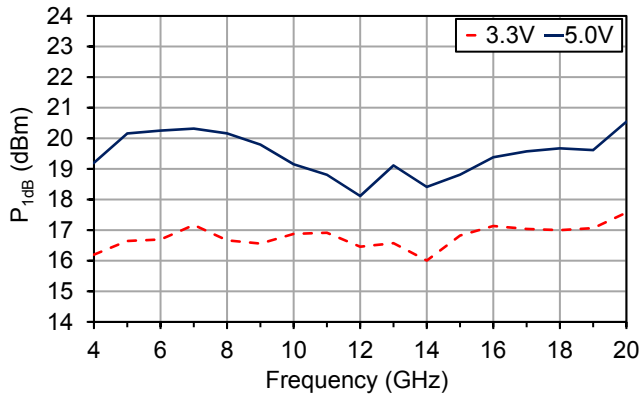
NF Over Temperature, $V_{DD} = 5.0V$



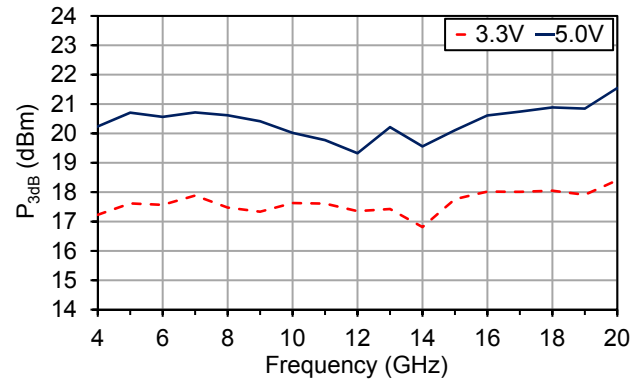
Typical Performance, RF Probe

$V_{D1} = V_{D2} = 5V$, $I_{DD} = 105mA$, $T_A = 25^\circ C$ unless otherwise noted

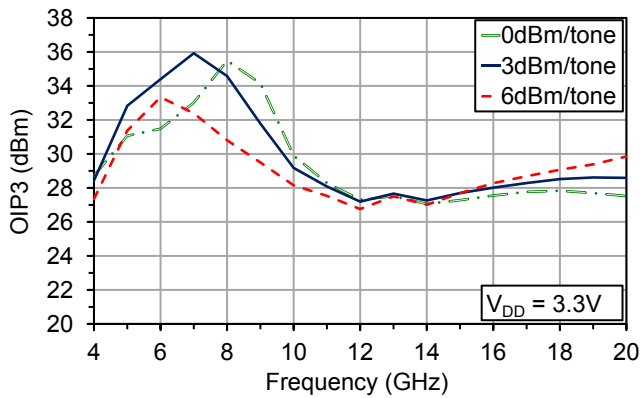
P_{1dB} Over V_{DD}



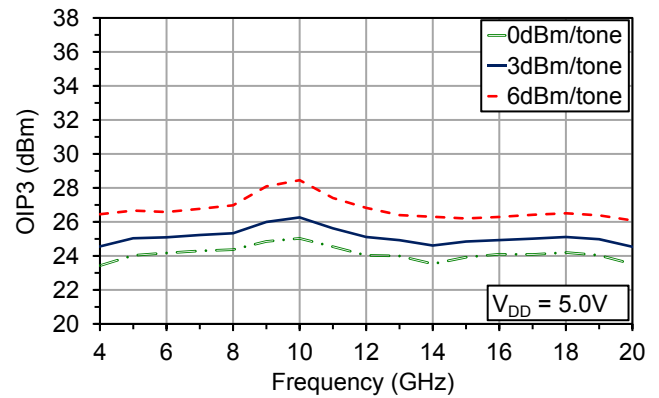
P_{3dB} Over V_{DD}



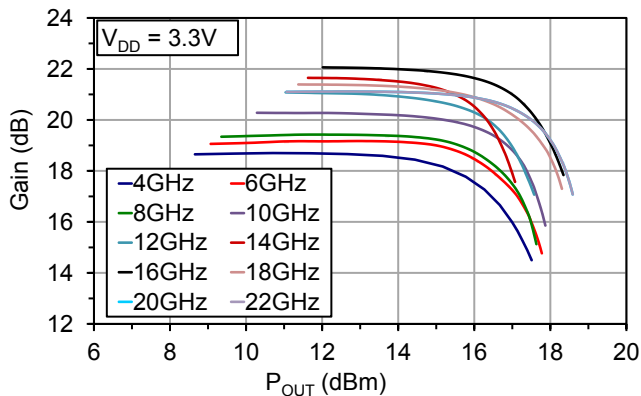
OIP3, $V_{DD} = 3.3V$



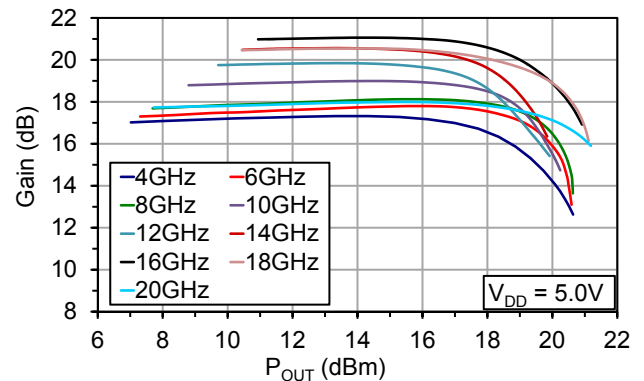
OIP3, $V_{DD} = 5.0V$



Power Sweep, $V_{DD} = 3.3V$



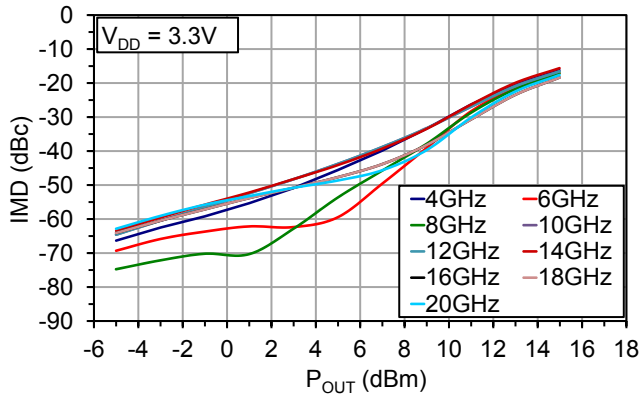
Power Sweep, $V_{DD} = 5.0V$



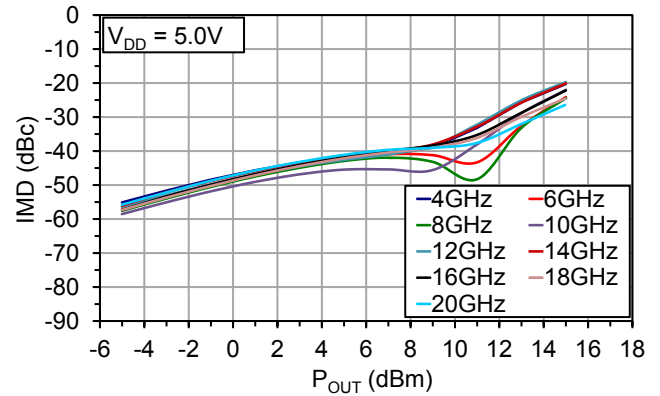
Typical Performance, RF Probe

$V_{D1} = V_{D2} = 5V$, $I_{DD} = 105mA$, $T_A = 25^\circ C$ unless otherwise noted

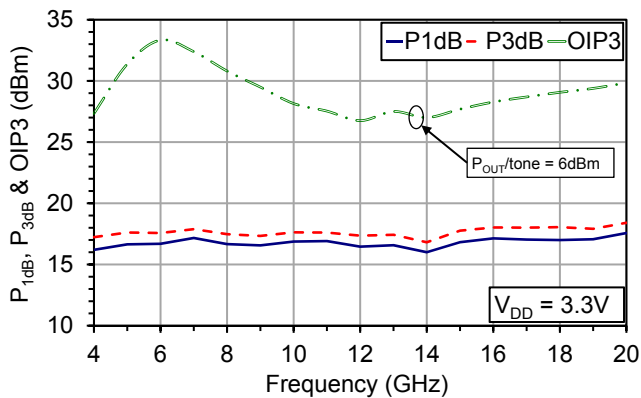
IMD Sweep, $V_{DD} = 3.3V$



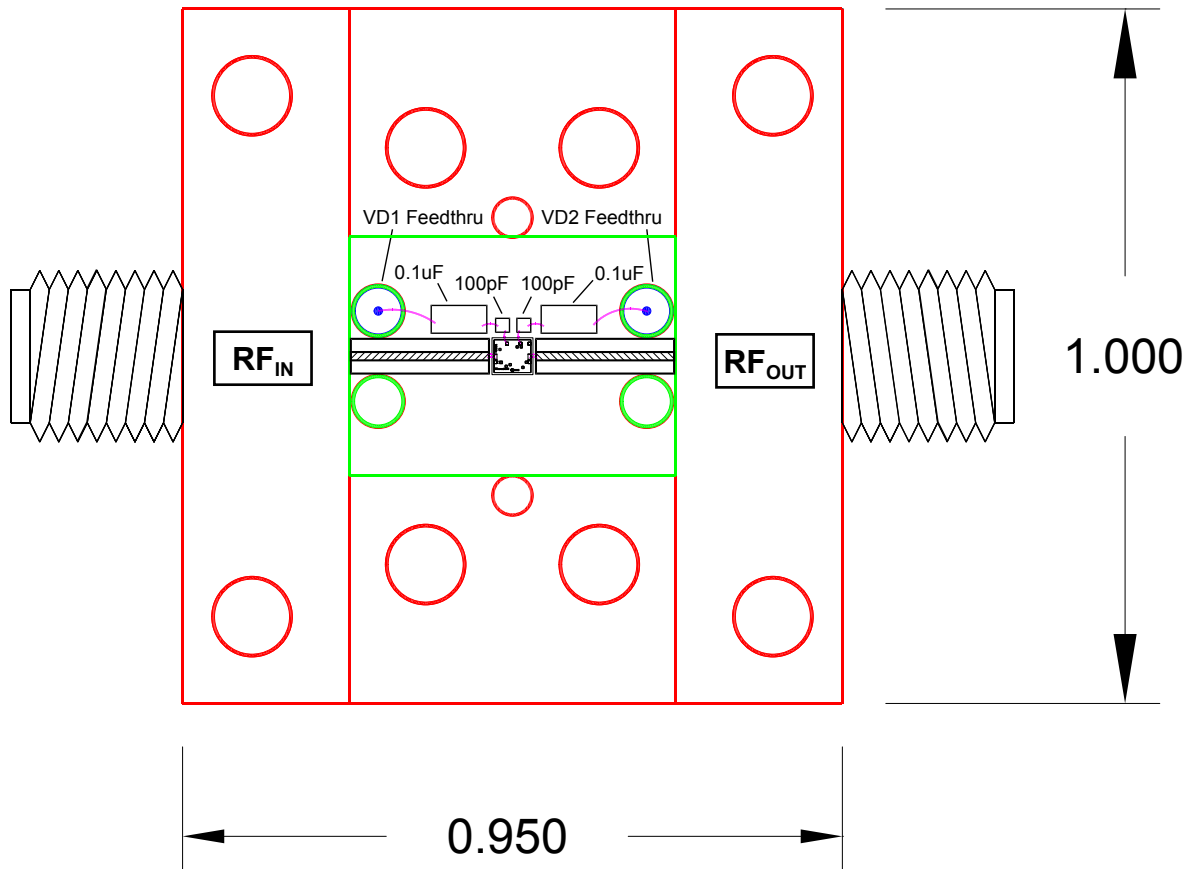
IMD Sweep, $V_{DD} = 5.0V$



Power and OIP3, $V_{DD} = 3.3V$



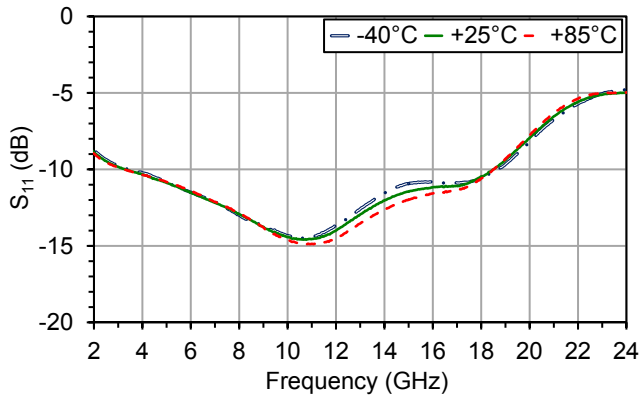
Connectorized Test Fixture With SMK 2.92mm Connectors



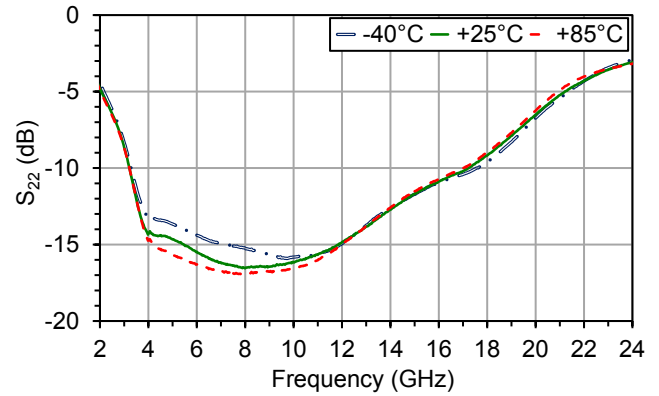
Typical Performance, Connectorized Test Fixture

$V_{D1} = V_{D2} = 5V$, $I_{DD} = 105mA$, $T_A = 25^\circ C$ unless otherwise noted

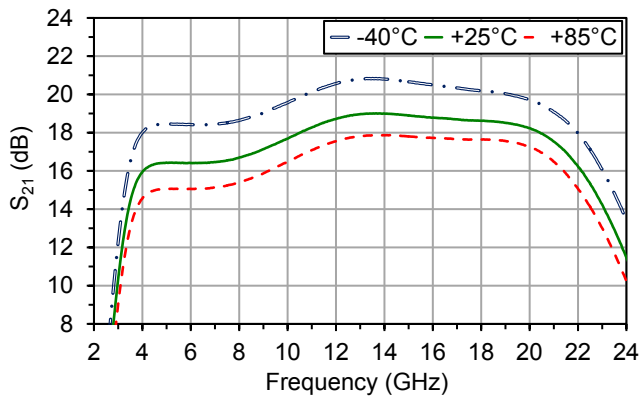
S_{11} Over Temperature



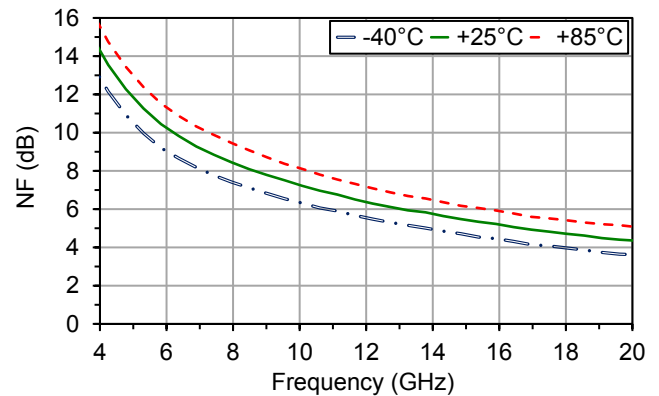
S_{22} Over Temperature



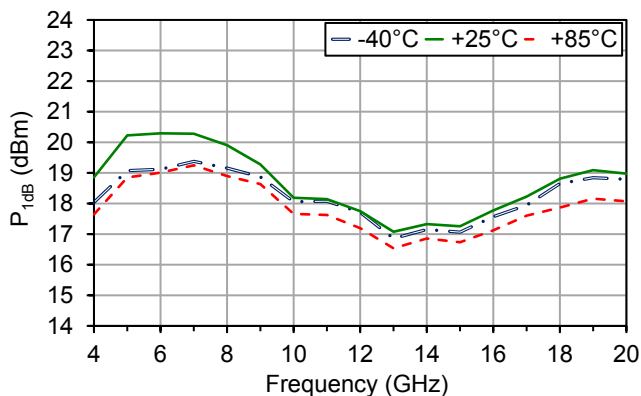
S_{21} Over Temperature



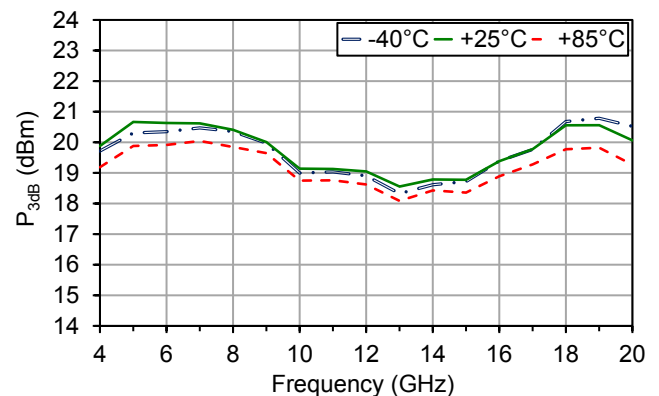
NF Over Temperature



P_{1dB} Over Temperature



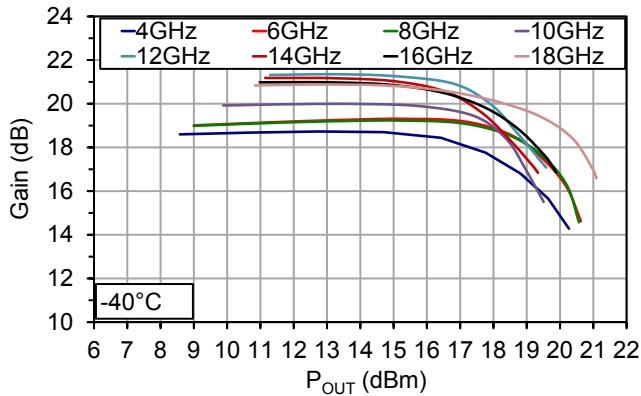
P_{3dB} Over Temperature



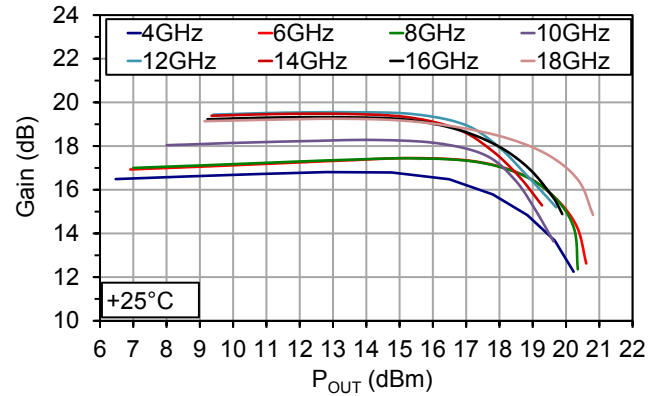
Typical Performance, Connectorized Test Fixture

$V_{D1} = V_{D2} = 5V$, $I_{DD} = 105mA$, $T_A = 25^\circ C$ unless otherwise noted

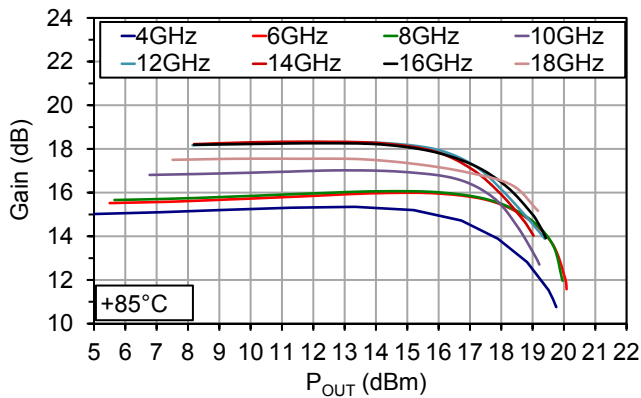
Power Sweep, $-40^\circ C$



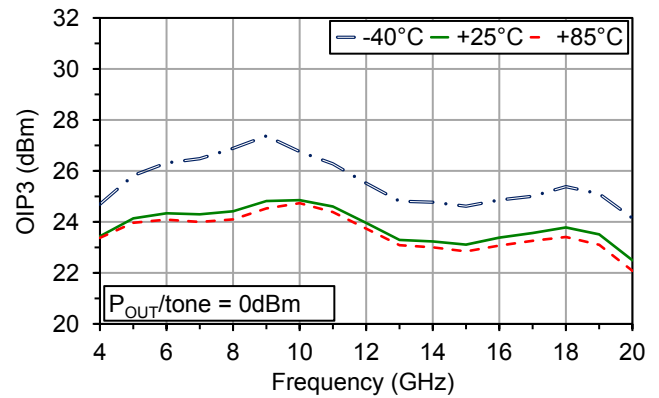
Power Sweep, $+25^\circ C$



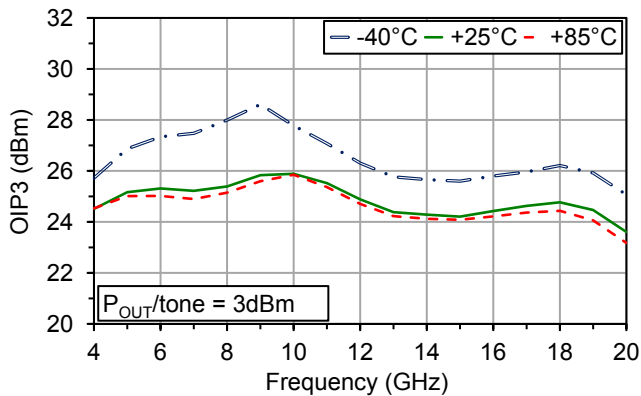
Power Sweep, $+85^\circ C$



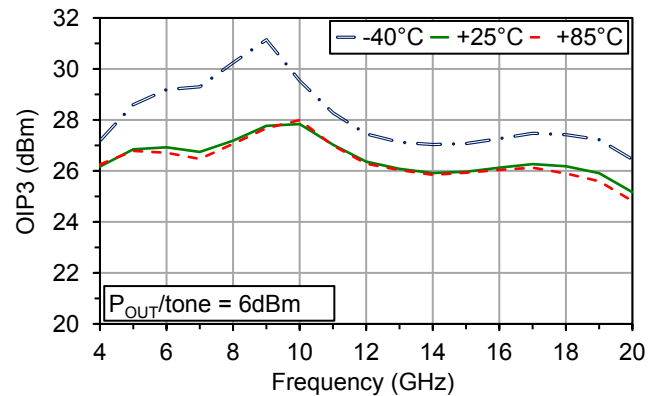
OIP3, $P_{OUT}/tone = 0dBm$



OIP3, $P_{OUT}/tone = 3dBm$



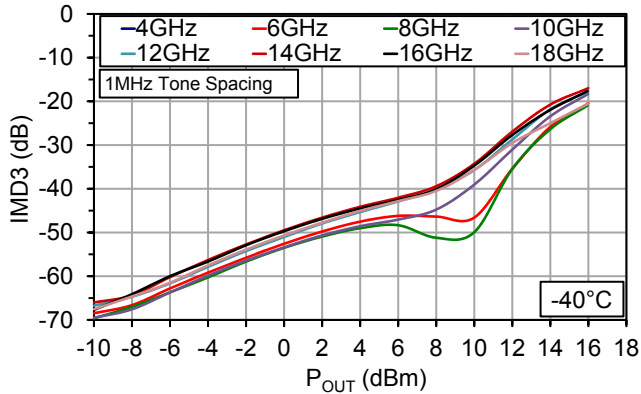
OIP3, $P_{OUT}/tone = 6dBm$



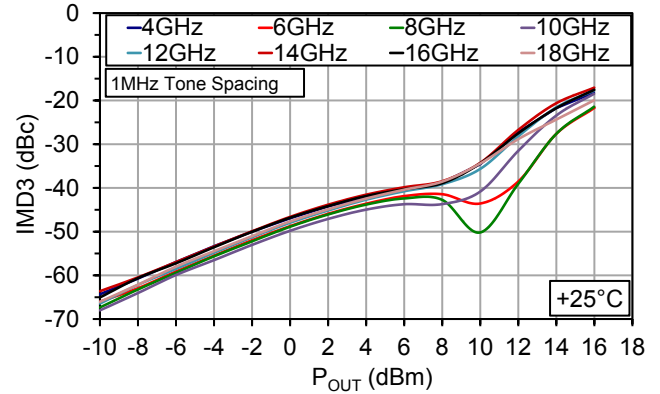
Typical Performance, Connectorized Test Fixture

$V_{D1} = V_{D2} = 5V$, $I_{DD} = 105mA$, $T_A = 25^\circ C$ unless otherwise noted

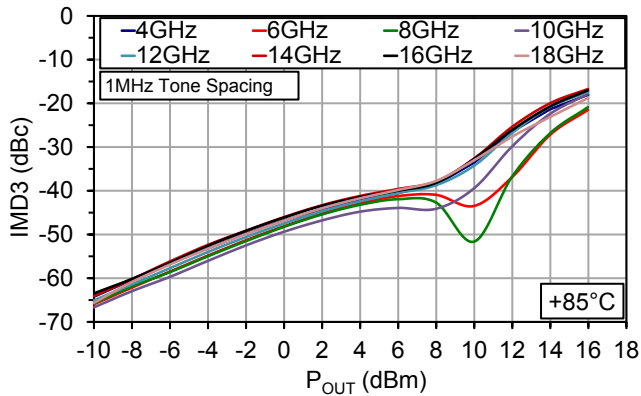
IMD3 Sweep, $-40^\circ C$



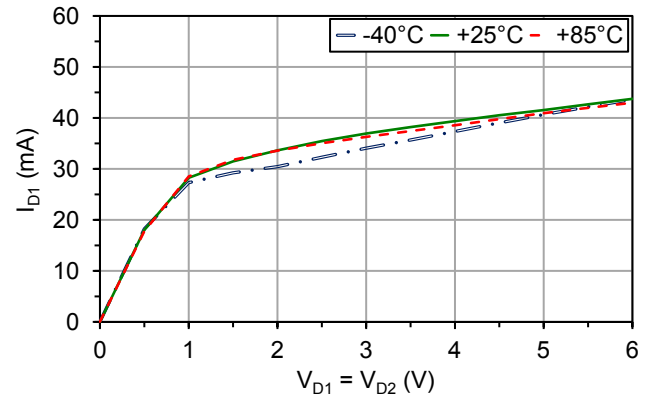
IMD3 Sweep, $+25^\circ C$



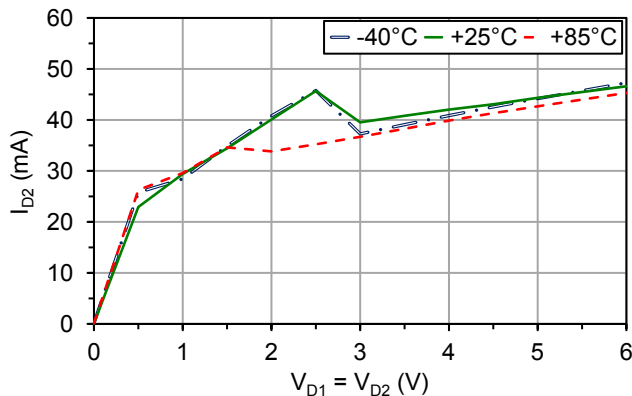
Power Sweep, $+85^\circ C$



DC, I_{D1}

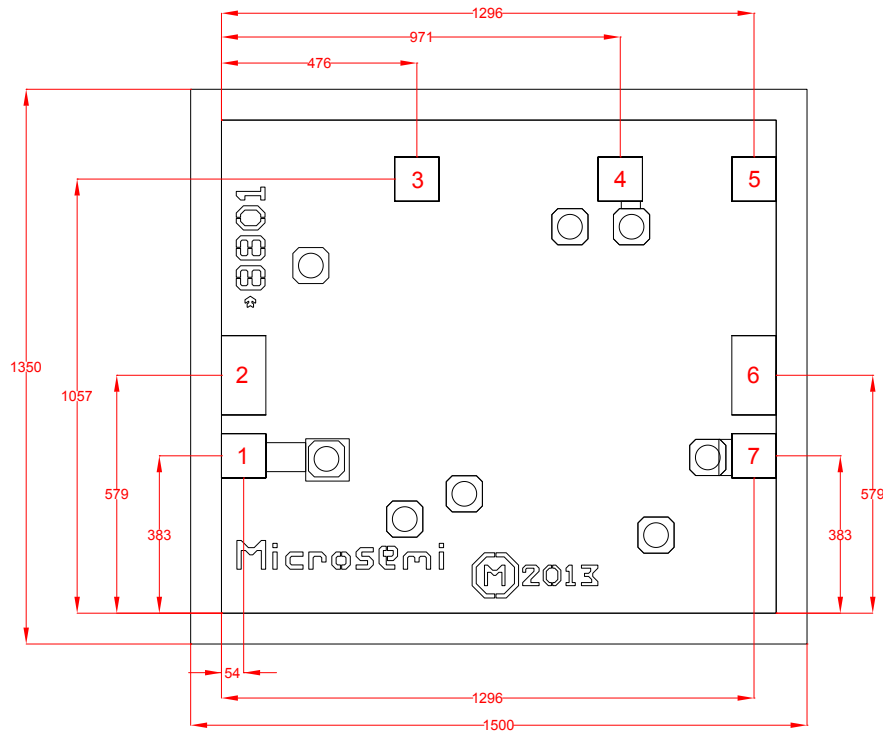


DC, I_{D2}



Chip layout showing pad locations.

All dimensions are in microns. Die thickness is 100 microns. Backside metal is gold, bond pad metal is gold. Refer to Die Handling Application Note MM-APP-0001 (visit www.microsemi.com/mmics).


Table 3: Pad Descriptions

Pad #	Description	Pad Dimensions (μm)
1, 4, 7	Ground	100 x 100
2	RF _{IN} , Pad is AC coupled	100 x 190
6	RF _{OUT} , Pad is AC coupled	100 x 190
3	V _{D1}	100 x 100
5	V _{D2}	100 x 100

Biasing

MMA002AA is self-biased. Apply 5V to V_{D1} and V_{D2}. Bias sequence does not matter.

Information contained in this document is proprietary to Microsem. This document may not be modified in any way without the express written consent of Microsemi. Product processing does not necessarily include testing of all parameters. Microsemi reserves the right to change the configuration and performance of the product and to discontinue product at any time.

Microsemi Corporate Headquarters

One Enterprise, Aliso Viejo CA 92656 USA
Within the USA: +1 (949) 380-6100
Sales: +1 (949) 380-6136
Fax: +1 (949) 215-4996

Microsemi Corporation (Nasdaq: MSCC) offers a comprehensive portfolio of semiconductor and system solutions for communications, defense and security, aerospace, and industrial markets. Products include high-performance and radiation-hardened analog mixed-signal integrated circuits, FPGAs, SoCs, and ASICs; power management products; timing and synchronization devices and precise time solutions, setting the world's standard for time; voice processing devices; RF solutions; discrete components; security technologies and scalable anti-tamper products; Power-over-Ethernet ICs and midspans; as well as custom design capabilities and services. Microsemi is headquartered in Aliso Viejo, Calif. and has approximately 3,400 employees globally. Learn more at www.microsemi.com.

© 2014 Microsemi Corporation. All rights reserved. Microsemi and the Microsemi logo are trademarks of Microsemi Corporation. All other trademarks and service marks are the property of their respective owners.